Unit in mm

1. EMITTER 2. COLLECTOR 3. BASE

TOSHIBA TRANSISTOR SILICON PNP EPITAXIAL TYPE (PCT PROCESS)

# 2 S A 1 8 9 1

### POWER AMPLIFIER APPLICATIONS

## POWER SWITCHING APPLICATIONS

Low Collector Saturation Voltage

:  $V_{CE (sat)} = -0.5 V (Max.) (I_{C} = -1A)$ 

High Collector Power Dissipation : PC=1.3W (Ta=25°C)

High Speed Switching Time :  $t_{stg} = 300 ns (Typ.)$ 

Complementary to 2SC5028

#### MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Collector-Base Voltage	$v_{\mathrm{CBO}}$	-60	V
Collector-Emitter Voltage	$v_{CEO}$	-50	V
Emitter-Base Voltage	$v_{ m EBO}$	-6	V
Collector Current	$I_{\mathbf{C}}$	_2	A
Base Current	$I_{\mathbf{B}}$	-0.2	Α
Collector Power Dissipation	$P_{\mathbf{C}}$	1.3	W
Junction Temperature	$T_j$	150	°C
Storage Temperature Range	$ m T_{stg}$	-55~150	°C

 $1.05 \pm 0.1$ + 0.15 0.5 - 0.05 2.5 ± 0.5

**JEDEC EIAJ TOSHIBA** 2-8M1A

Weight: 0.55g

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# ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARAC'	TERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Collector Cut-o	off Current	$I_{CBO}$	$V_{CB} = -60V, I_{E} = 0$	_	_	-1.0	$\mu$ A
Emitter Cut-of	f Current	$I_{EBO}$	$V_{EB} = -6V, I_C = 0$	_	_	-1.0	$\mu$ A
Collector-Emitt Voltage	er Breakdown	V (BR) CEO	$I_{\rm C} = -10 { m mA}, \ I_{\rm B} = 0$	-50	_	_	V
DC Current Gain		h <sub>FE (1)</sub>	$V_{CE} = -2V, I_{C} = -100 \text{mA}$	120	_	400	
		h <sub>FE (2)</sub>	$V_{CE} = -2V, I_{C} = -1.5A$	40	_	_	
Collector-Emitt Voltage	er Saturation	V <sub>CE (sat)</sub>	$I_C = -1A, I_B = -0.05A$	_	_	-0.5	V
Base-Emitter S Voltage	Saturation	V <sub>BE</sub> (sat)	$I_C = -1A, I_B = -0.05A$	_	_	-1.2	v
Transition Free	quency	$ m f_{T}$	$V_{CE} = -2V, I_{C} = -100 \text{mA}$	_	100	_	MHz
Collector Outpo	ut Capacitance	C <sub>ob</sub>	$V_{CB} = -10V, I_E = 0, f = 1MHz$	_	23	_	pF
Switching Time	Turn-on Time	ton	$I_{B1} \stackrel{20\mu \text{s}}{\longleftarrow} I_{B2} \stackrel{\text{INPUT}}{\longleftarrow} I_{B1} \stackrel{\text{B2}}{\longleftarrow} 0 UTPUT$	_	0.1		
	Storage Time	$t_{ ext{stg}}$			0.3	_	μs
	Fall Time	tf	$\begin{array}{ccc} -I_{B1} = I_{B2} = 0.05A & V_{CC} = \\ DUTY \ CYCLE \le 1\% & -30V \end{array}$	_	0.1	_	